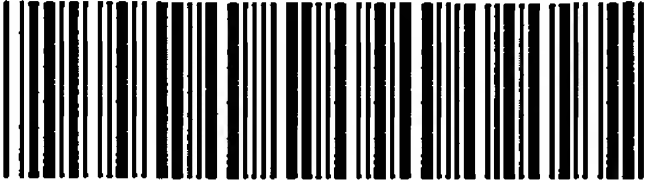


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/602,629	WATANABE, SHIGEKI	
	Examiner	Art Unit	
	John D. Lee	2874	

SEARCHED			
Class	Subclass	Date	Examiner
359	326-332	7/27/2005	JDL
359	107,108	7/27/2005	JDL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
359	326-332	7/27/2005	JDL
359	107,108	7/27/2005	JDL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Previous USPTO "WEST" Database search updated (same search terms)	7/27/2005	JDL